Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/606,270	SHIBATA, MICH	HHIRO
Examiner	Art Unit	
Tianjie Chen	2627	

SEARCHED				
Class	Subclass	Date	Examiner	
Updated		8/30/2006	TJ	
	_			

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
		<u> </u>			
	<u> </u>		 		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
	1)1			